Search Notes

Application/Control	No.

Applicant(s)/Patent under Reexamination
GURSKI ET AL.

10/002,063 Examiner

Art Unit

Thien D. Tran

2665

SEARCHED					
Class	Subclass	Date	Examiner		
		-			
		-			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
370	520	3/12/2006	тт	
	514	3/12/2006	TT	
-				

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST (USPGPUB, USPAT, USOCR, EPO, DERWENT) 370/320, 342, 441, 514, 520	3/12/2006	тт